Search Notes

Application No.	Applicant(s)	
09/635,830	LAYMAN ET AL.	
Examiner	**Art Unit**	
Quoc A. Tran	2176	

SEARCHED

Class	Subclass	Date	Examiner
715	501.1	1-24-05	
707	102 R		
707	3		
709	203		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
INVENTOR SEARCH CHECK FOR double-patent. US-PAT US-PGPUB	1/21/05	
EPO, JPO, DERWENT IBM-TDB INTERNET PLNS; EIC		
PERSONAL DIGESTS		